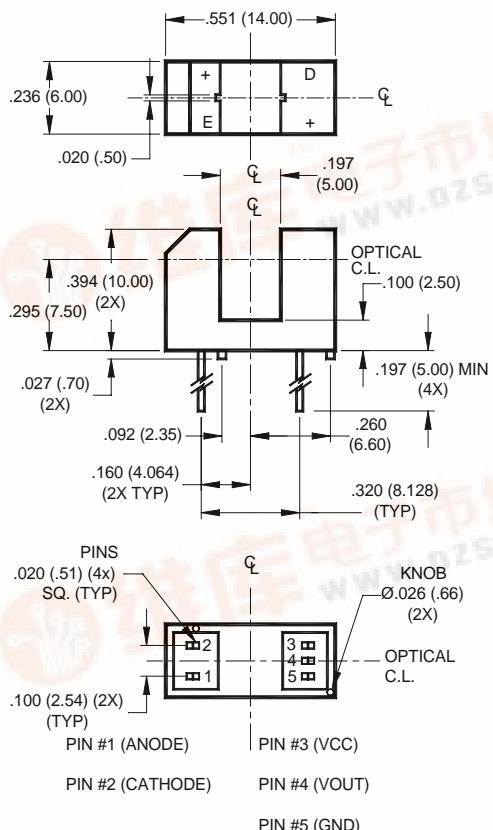
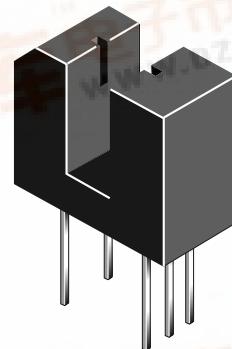


**OPTOLOGIC® OPTICAL  
INTERRUPTER SWITCH**
**PACKAGE DIMENSIONS**

**NOTES:**

- Dimensions for all drawings are in inches (millimeters).
- Tolerance of  $\pm .010$  (.25) on all non-nominal dimensions unless otherwise specified.


**FEATURES**

- No contact switching
- 5.0 mm wide slot
- 0.5 mm aperture width
- Opaque black plastic housing
- Output configuration: Buffer open-collector
- TTL/CMOS compatible output
- Locating knobs on housing base for accurate mounting

**NOTES** (Applies to Max Ratings and Characteristics Tables.)

- Derate power dissipation linearly 1.67 mW/°C above 25°C.
- Derate power dissipation linearly 2.50 mW/°C above 25°C.
- RMA flux is recommended.
- Methanol or isopropyl alcohols are recommended as cleaning agents.
- Soldering iron 1/16" (1.6mm) from housing.
- As long as leads are not under any stress or spring tension.

**ABSOLUTE MAXIMUM RATINGS** ( $T_A = 25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Rating	Units
Operating Temperature	$T_{OPR}$	-40 to +85	°C
Storage Temperature	$T_{STG}$	-40 to +85	°C
Lead Temperature (Solder Iron) <sup>(3,4,5,6)</sup>	$T_{SOL-I}$	240 for 5 sec	°C
Lead Temperature (Solder Flow) <sup>(3,4,5,6)</sup>	$T_{SOL-F}$	260 for 10 sec	°C
<b>EMITTER</b>			
Continuous Forward Current	$I_F$	50	mA
Reverse Voltage	$V_R$	5	V
Power Dissipation <sup>(1)</sup>	$P_D$	100	mW
<b>SENSOR</b>			
Output Current	$I_O$	50	mA
Supply Voltage	$V_{CC}$	16	V
Output Voltage	$V_O$	30	V
Power Dissipation <sup>(2)</sup>	$P_D$	150	mW

**ELECTRICAL / OPTICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ )**

PARAMETER	TEST CONDITIONS	SYMBOL	MIN.	TYP.	MAX.	UNITS
Operating Supply Voltage		$V_{CC}$	4.5		16	V
<b>INPUT DIODE</b>						
Forward Voltage	$I_F = 20 \text{ mA}$	$V_F$	—		1.7	V
Reverse Leakage Current	$V_R = 5 \text{ V}$	$I_R$	—		10	$\mu\text{A}$
<b>COUPLED</b>						
Operating Supply Current	$I_F = 15 \text{ mA}$ or $0 \text{ mA}$ , $V_{CC} = 16 \text{ V}$	$I_{CC}$	—		5	mA
Low Level Output Voltage	$I_F = 15 \text{ mA}$ , $V_{CC} = 5 \text{ V}$ , $R_L = 360 \Omega$	$V_{OL}$	—		0.4	V
High Level Output Current	$I_F = 0 \text{ mA}$ , $V_{CC} = 5 \text{ V}$ , $V_{OH} = 30 \text{ V}$	$I_{OH}$	—		100	$\mu\text{A}$
Turn on Threshold Current	$V_{CC} = 5 \text{ V}$ , $R_L = 360 \Omega$	$I_F(+)$	—		15	mA
Turn off Threshold Current	$V_{CC} = 5 \text{ V}$ , $R_L = 360 \Omega$	$I_F(-)$	0.50		—	mA
Hysteresis Ratio		$I_F(+)$ / $I_F(-)$			1.2	
Propagation Delay	$V_{CC} = 5 \text{ V}$ , $R_L = 360 \Omega$	$t_{PLH}, t_{PHL}$			5	$\mu\text{s}$
Output Rise and Fall Time	$V_{CC} = 5 \text{ V}$ , $R_L = 360 \Omega$	$t_r, t_f$			70	ns

**TYPICAL PERFORMANCE CURVES**

Fig. 1 Output Voltage vs. Input Current

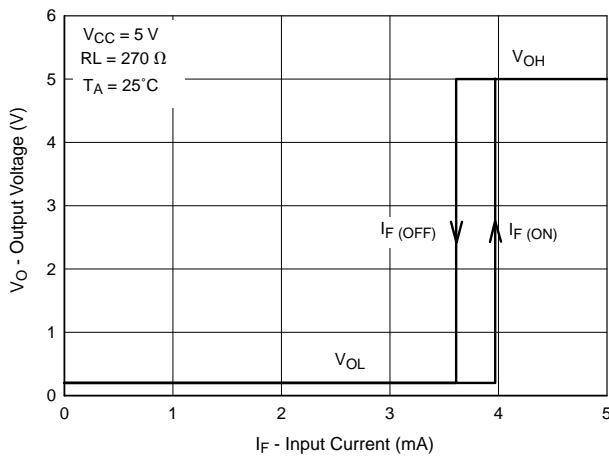
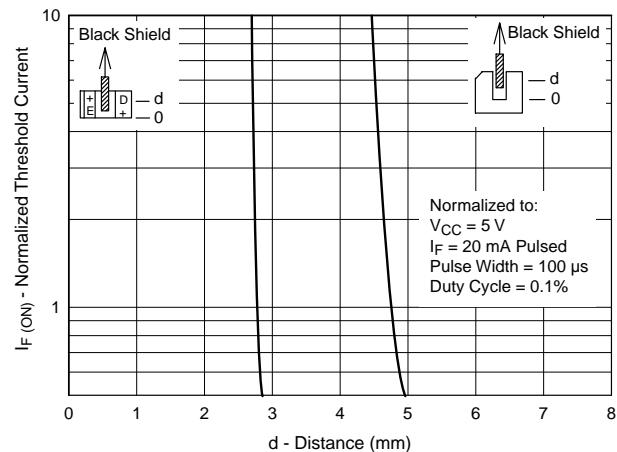
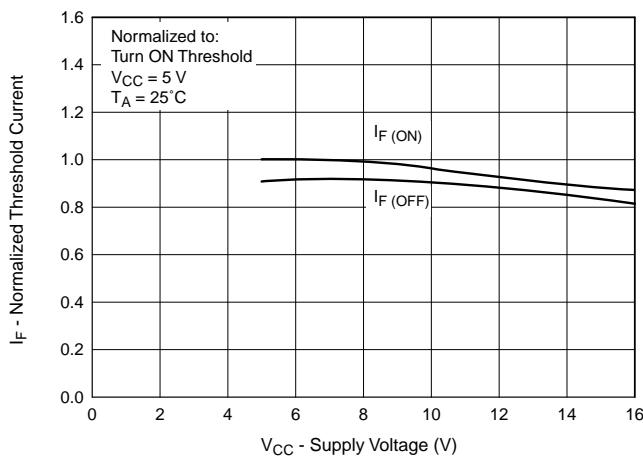


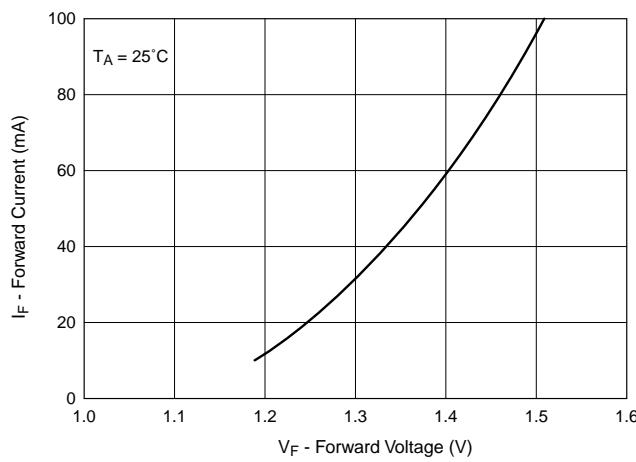
Fig. 2 Normalized Threshold Current vs. Shield Distance



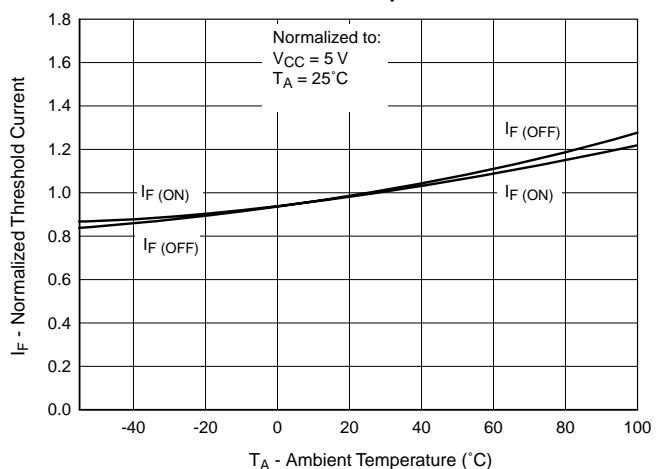
**Fig. 3 Normalized Threshold Current vs. Supply Voltage**



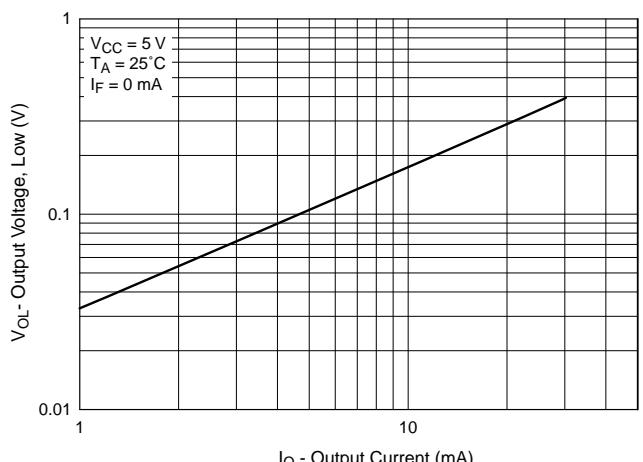
**Fig. 5 Forward Current vs. Forward Voltage**



**Fig. 4 Normalized Threshold Current vs. Ambient Temperature**



**Fig. 6 Low Output Voltage vs. Output Current**



**Fig. 7 Response Time vs. Forward Current**

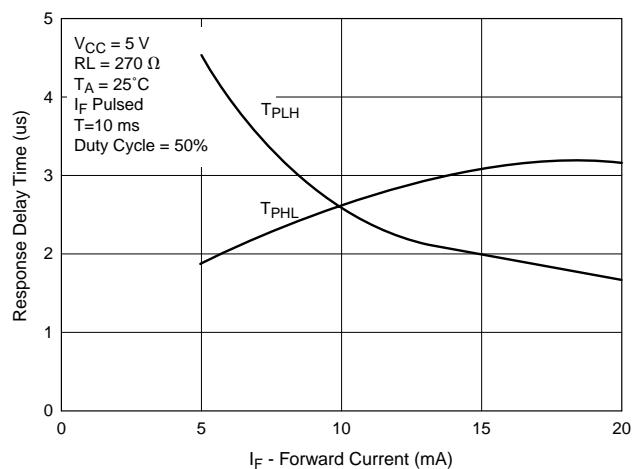
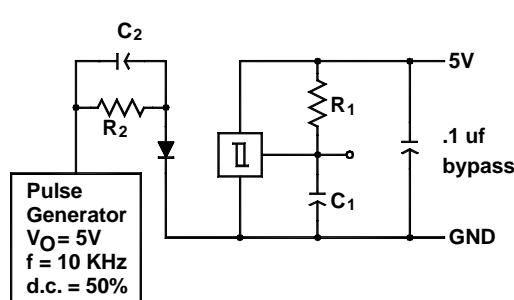


Fig. 8 Switching Speed Test Circuit



$R_1 = 270 \Omega$   
 $R_2 = 360 \Omega$

$C_1 = 15 \text{ pf}$   
 $C_2 = 20 \text{ pf}$

$C_1$  and  $C_2$  include probe and  
stray wire capacitance

Fig. 9 Typical Operating Circuit

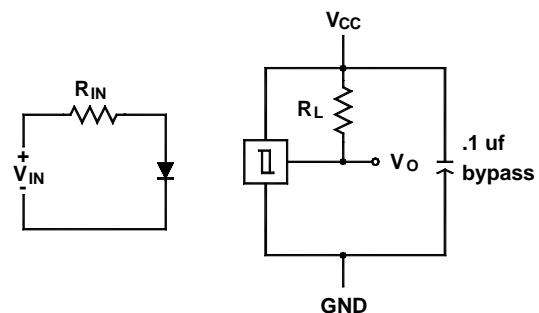


Fig. 10 Switching Test Curve for Buffers

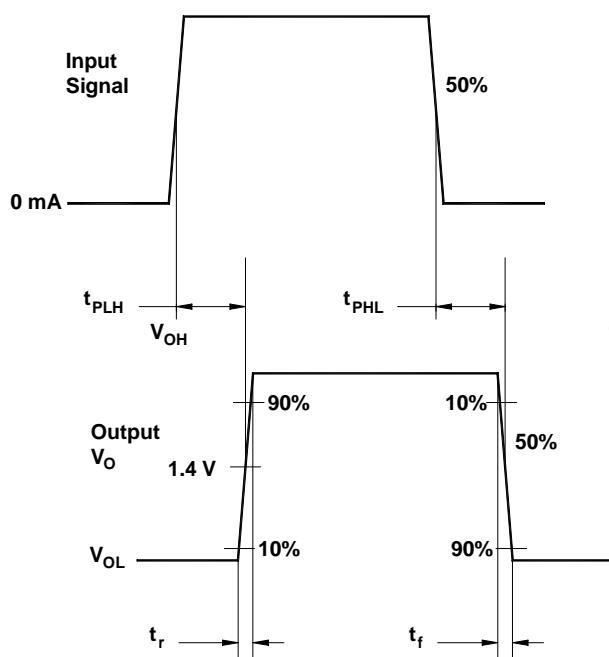
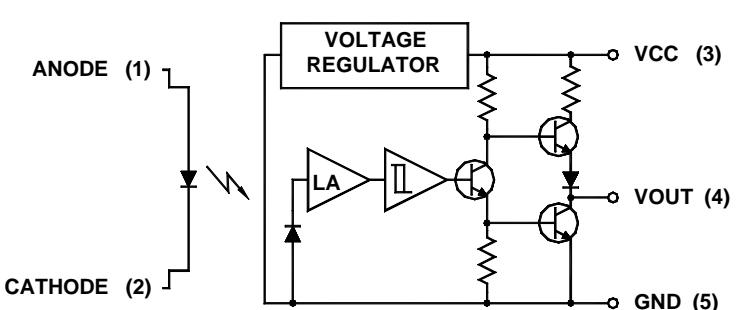


Fig. 11 Switching Test Curve for Inverters





**QVE00120**

**OPTOLOGIC® OPTICAL  
INTERRUPTER SWITCH**

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.